Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/501,423 Examiner	GEIJTENBEEK ET AL	··
Binh V. Ho	2163	

SEARCHED			
Class	Subclass	Date	Examiner
313	631	7/6/2006	вн
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT	ES STRATEGY)	
	DATE	EXMR
313/631,25,573,623,634,635,640,641, 567,607,600,558,632,635 East search (see printout)	7/6/2006	ВН
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